FAIRCHILD SEMICONDUCTOR®

August 2002

FDS8333C

30V N & P-Channel PowerTrench® MOSFETs

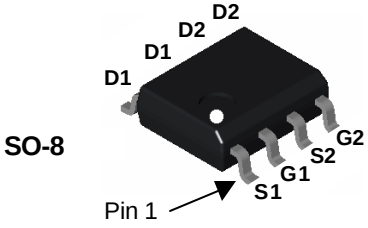
General Description

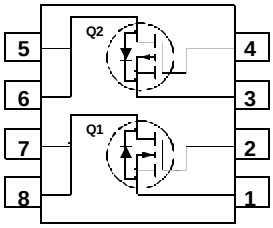
These N & P-Channel MOSFETs are produced using Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize on-state resistance and yet maintain superior switching performance.

These devices are well suited for low voltage and battery powered applications where low in-line power loss and fast switching are required.

Features

- **Q1** 4.1 A, 30V. $R_{DS(ON)}$ = 80 mΩ @ V_{GS} = 10 V
  $R_{DS(ON)}$ = 130 mΩ @ V_{GS} = 4.5 V
- **Q2** –3.4 A, 30V. $R_{DS(ON)}$ = 130 mΩ @ V_{GS} = –10 V
  $R_{DS(ON)}$ = 200 mΩ @ V_{GS} = –4.5 V
- Low gate charge
- High performance trench technology for extremely low $R_{DS(ON)}$.
- High power and handling capability in a widely used surface mount package.





Absolute Maximum Ratings

T_A=25°C unless otherwise noted

Symbol	Parameter		Q1	Q2	Units
V_{DSS}	Drain-Source Voltage		30	–30	V
V_{GSS}	Gate-Source Voltage		±16	±20	
I_D	Drain Current – Continuous	(Note 1a)	4.1	–3.4	A
	– Pulsed		20	–20	
P_D	Power Dissipation for Dual Operation		2		W
	Power Dissipation for Single Operation	(Note 1a)	1.6		
		(Note 1b)	1		
		(Note 1c)	0.9		
T_J, T_{STG}	Operating and Storage Junction Temperature Range		–55 to +150		°C

Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	78	°C/W
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	(Note 1)	40	

Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape width	Quantity
FDS8333C	FDS8333C	7"	12mm	2500 units

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Electrical Characteristics

T_A = 25°C unless otherwise noted

Symbol	Parameter		Test Conditions		Min	Typ	Max	Units
Off Characteristics								
BV_{DSS}	Drain–Source Breakdown Voltage		V_{GS} = 0 V, I_D = 250 µA V_{GS} = 0 V, I_D = –250 µA	**Q1** **Q2**	30 –30			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient		I_D = 250 µA,Ref. to 25°C I_D = –250 µA,Ref. to 25°C	**Q1** **Q2**		25 –22		mV/°C
I_{DSS}	Zero Gate Voltage Drain Current		V_{DS} = 24 V, V_{GS} = 0 V V_{DS} = –24 V, V_{GS} = 0 V	**Q1** **Q2**			1 –1	µA
I_{GSSF} /I_{GSSR}	Gate–Body Leakage, Forward		V_{GS} = ± 16 V, V_{DS} = 0 V				±100	nA
I_{GSSF} /I_{GSSR}	Gate–Body Leakage, Reverse		V_{GS} = ± 20V , V_{DS} = 0 V				±100	nA
On Characteristics (Note 2)								
$V_{GS(th)}$	Gate Threshold Voltage	**Q1**	V_{DS} = V_{GS}, I_D = 250 µA		1	1.7	3	V
		Q2	V_{DS} = V_{GS}, I_D = –250 µA		–1	–1.8	–3	
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient		I_D = 250 µA,Ref. To 25°C I_D = –250 µA,Ref. to 25°C	**Q1** **Q2**		–4.2 3.7		mV/°C
$R_{DS(on)}$	Static Drain–Source On–Resistance	**Q1**	V_{GS} = 10 V, I_D = 4.1 A V_{GS} = 4.5 V, I_D = 3.2 A V_{GS} = 10 V, I_D = 4.1 A T_J=125°C			67 81 103	80 130 145	mΩ
		Q2	V_{GS} = –10 V, I_D = –3.4 A V_{GS} = – 4.5 V, I_D = –2.5 A V_{GS} = –10V,I_D = –3.4A, T_J=125°C			105 167 147	130 200 220	
$I_{D(on)}$	On–State Drain Current	**Q1**	V_{GS} = 10 V, V_{DS} = 5 V		10			A
		Q2	V_{GS} = –10 V, V_{DS} = –5 V		–5			
g_{FS}	Forward Transconductance	**Q1**	V_{DS} = 5 V I_D = 4.1 A			9		S
		Q2	V_{DS} = –5 V I_D = –3.4A			5		
Dynamic Characteristics								
C_{iss}	Input Capacitance	**Q1**	V_{DS}=10 V, V_{GS}= 0 V, f=1.0MHz			282		pF
		Q2	V_{DS}=–10 V, V_{GS}= 0 V, f=1.0MHz			185		
C_{oss}	Output Capacitance	**Q1**	V_{DS}=10 V, V_{GS}= 0 V, f=1.0MHz			49		pF
		Q2	V_{DS}=–10 V, V_{GS}= 0 V, f=1.0MHz			56		
C_{rss}	Reverse Transfer Capacitance	**Q1**	V_{DS}=10 V, V_{GS}= 0 V, f=1.0MHz			20		pF
		Q2	V_{DS}=–10 V, V_{GS}= 0 V, f=1.0MHz			26		
R_G	Gate Resistance	**Q1**	V_{GS}= 15 mV, f=1.0MHz			2.3		Ω
		Q2	V_{GS}=–15 mV, f=1.0MHz			–9.6		
Switching Characteristics (Note 2)								
$t_{d(on)}$	Turn–On Delay Time	**Q1**	For **Q1**: V_{DS} =10 V, I_{DS}= 1 A V_{GS}= 4.5 V, R_{GEN} = 6 Ω For **Q2**: V_{DS} =–10 V, I_{DS}= –1 A V_{GS}= –4.5 V, R_{GEN} = 6 Ω			4.5	9	ns
		Q2				4.5	9	
t_r	Turn–On Rise Time	**Q1**				6	12	ns
		Q2				13	23	
$t_{d(off)}$	Turn–Off Delay Time	**Q1**				19	34	ns
		Q2				11	20	
t_f	Turn–Off Fall Time	**Q1**				1.5	3	ns
		Q2				2	4	
Q_g	Total Gate Charge	**Q1**	For **Q1**: V_{DS} =10 V, I_{DS}= 4.1 A V_{GS}= 4.5 V, R_{GEN} = 6 Ω For **Q2**: V_{DS} =–10 V, I_{DS}= –3.4 A V_{GS}= –4.5 V,			4.7	6.6	nC
		Q2				4.1	5.7	
Q_{gs}	Gate–Source Charge	**Q1**				0.9		nC
		Q2				0.8		
Q_{gd}	Gate–Drain Charge	**Q1**				0.6		nC
		Q2				0.4		

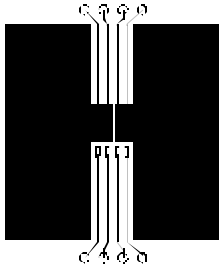
Electrical Characteristics

T_A = 25°C unless otherwise noted

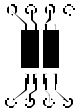
Symbol	Parameter		Test Conditions	Min	Typ	Max	Units
Drain–Source Diode Characteristics and Maximum Ratings							
V_{SD}	Drain–Source Diode Forward Voltage	**Q1**	V_{GS} = 0 V, I_S = 1.3 A (Note 2)		0.8	1.2	V
		Q2	V_{GS} = 0 V, I_S = –1.3 A (Note 2)		0.8	–1.2	
t_{rr}	Diode Reverse Recovery Time	**Q1**	I_F = 4.1 A, d_{iF}/d_t = 100 A/µs		16.3		nS
		Q2	I_F = –3.4 A, d_{iF}/d_t = 100 A/µs		14.5		
Q_{rr}	Diode Reverse Recovery Charge	**Q1**	I_F = 4.1 A, d_{iF}/d_t = 100 A/µs		26.7		nC
		Q2	I_F = –3.4 A, d_{iF}/d_t = 100 A/µs		21.1		

Notes:

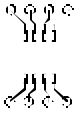
1. $R_{\theta JA}$ is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



a) 78°C/W when mounted on a 0.5in^2 pad of 2 oz copper



b) 125°C/W when mounted on a 0.02 in^2 pad of 2 oz copper



c) 135°C/W when mounted on a minimum pad.

Scale 1 : 1 on letter size paper

2. Pulse Test: Pulse Width < 300µs, Duty Cycle < 2.0%

Typical Characteristics: N-Channel

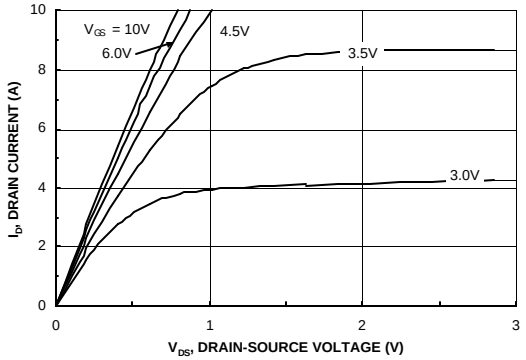


Figure 1. On-Region Characteristics.

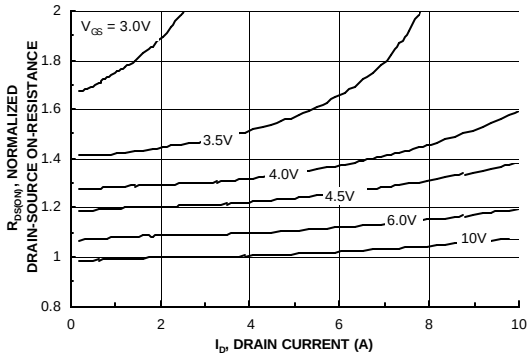


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

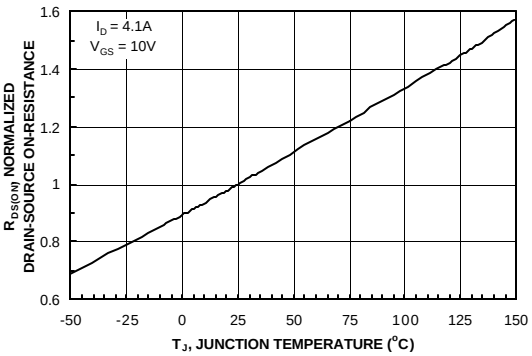


Figure 3. On-Resistance Variation withTemperature.

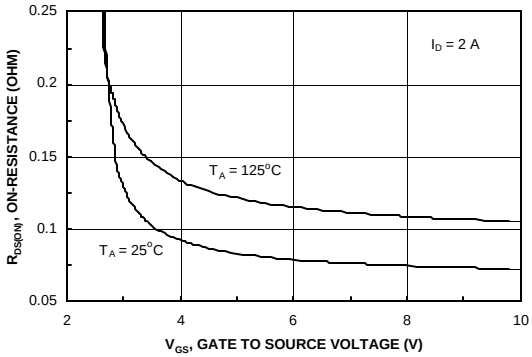


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

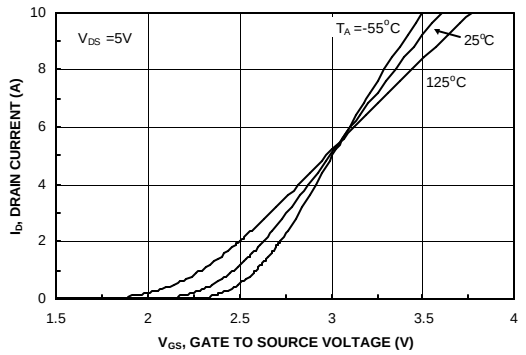


Figure 5. Transfer Characteristics.

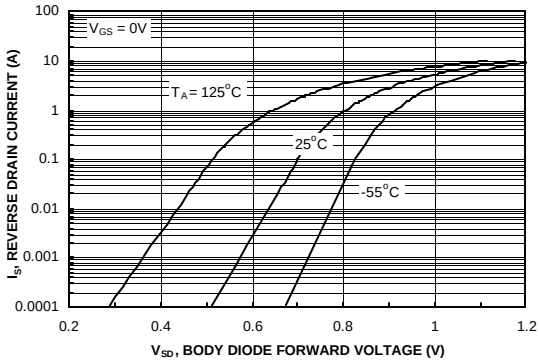


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Characteristics: N-Channel (continued)

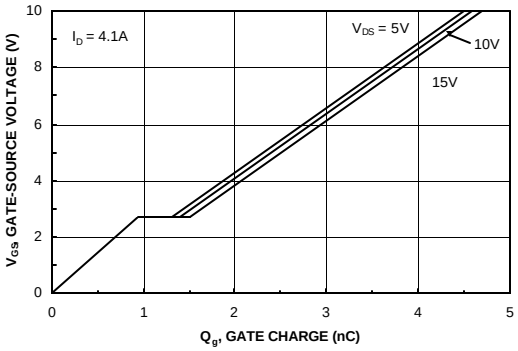


Figure 7. Gate Charge Characteristics.

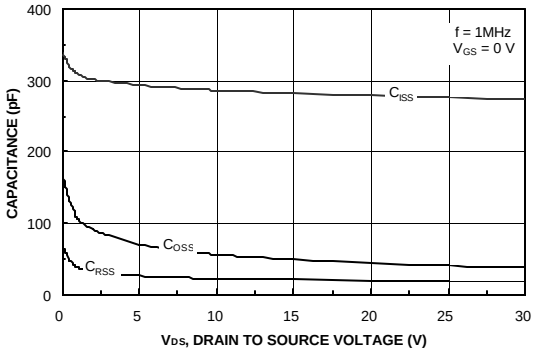


Figure 8. Capacitance Characteristics.

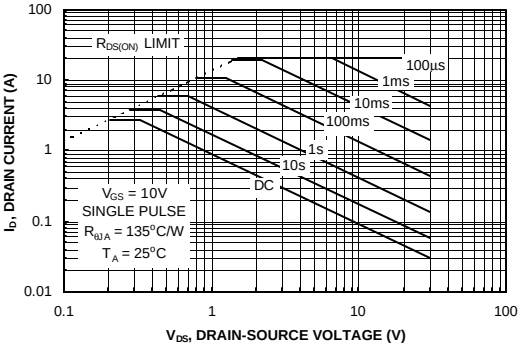


Figure 9. Maximum Safe Operating Area.

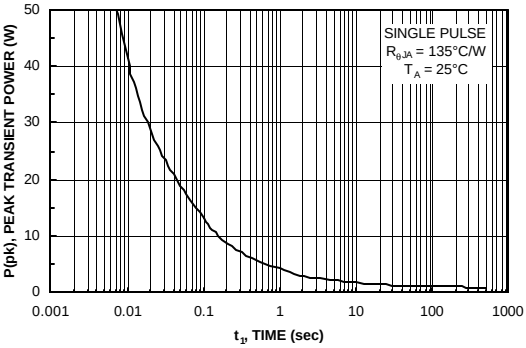


Figure 10. Single Pulse Maximum Power Dissipation.

Typical Characteristics: P-Channel

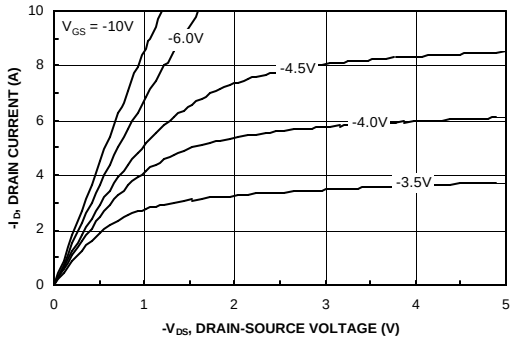


Figure 11. On-Region Characteristics.

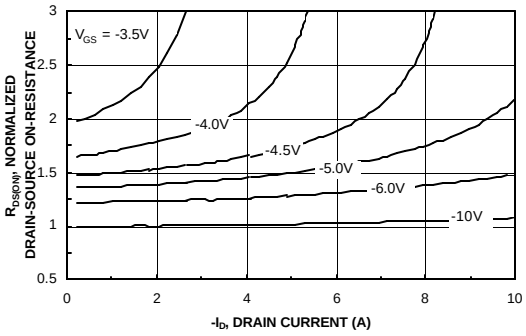


Figure 12. On-Resistance Variation with Drain Current and Gate Voltage.

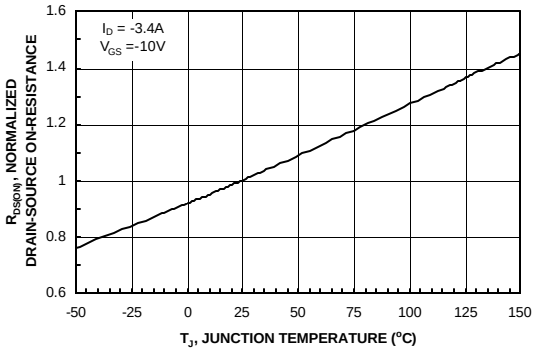


Figure 13. On-Resistance Variation withTemperature.

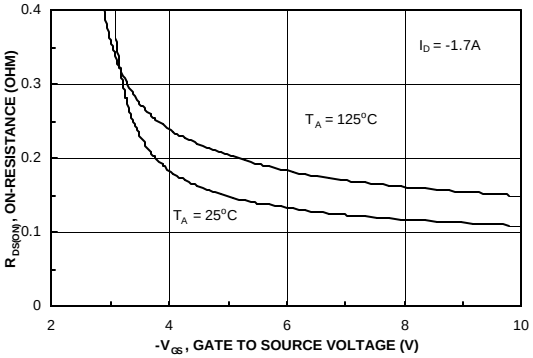


Figure 14. On-Resistance Variation with Gate-to-Source Voltage.

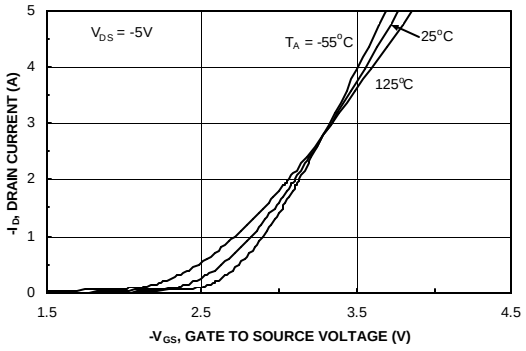


Figure 15. Transfer Characteristics.

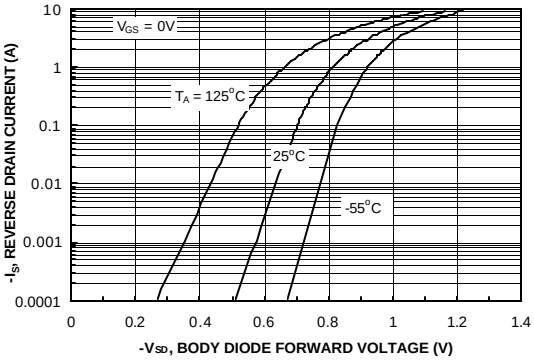


Figure 16. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Characteristics: P-Channel (continued)

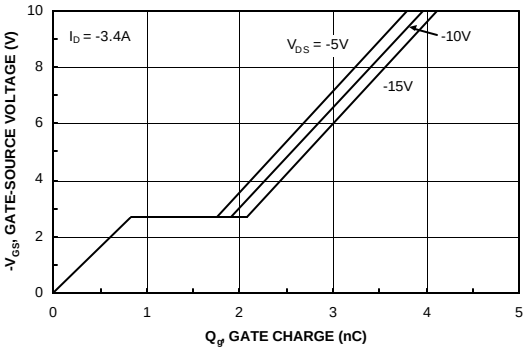


Figure 17. Gate Charge Characteristics.

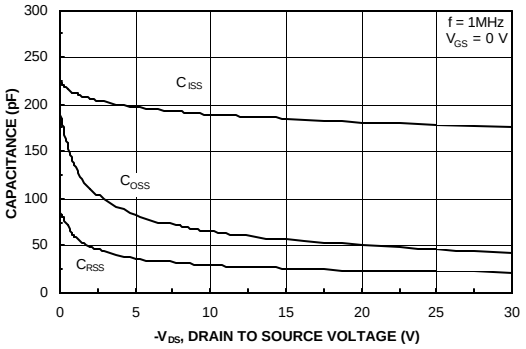


Figure 18. Capacitance Characteristics.

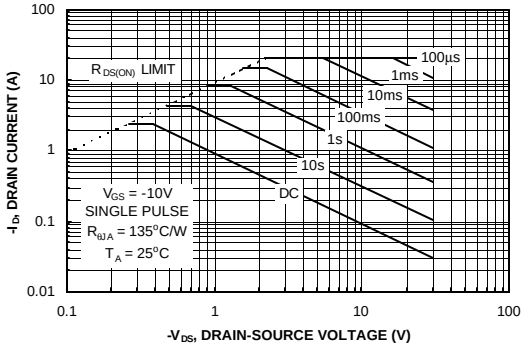


Figure 19. Maximum Safe Operating Area.

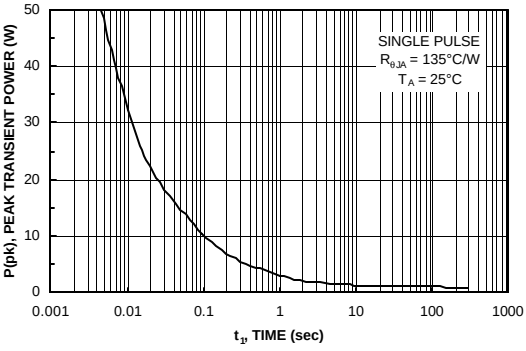


Figure 20. Single Pulse Maximum Power Dissipation.

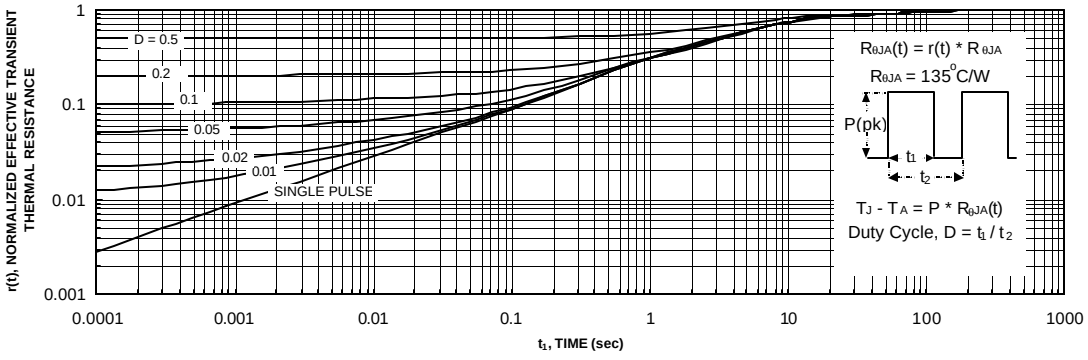


Figure 21. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1c.
Transient thermal response will change depending on the circuit board design.

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Компания «Океан Электроники» является официальным дистрибьютором и эксклюзивным представителем в России одного из крупнейших производителей разъемов военного и аэрокосмического назначения «**JONHON**», а так же официальным дистрибьютором и эксклюзивным представителем в России производителя высокотехнологичных и надежных решений для передачи СВЧ сигналов «**FORSTAR**».

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